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2-input NAND gate Rev. 5 — 25 September 2013

#### 1. **General description**

The 74HC1G00; 74HCT1G00 is a single 2-input NAND gate. Inputs include clamp diodes that enable the use of current limiting resistors to interface inputs to voltages in excess of V<sub>CC</sub>.

#### Features and benefits 2.

- Wide supply voltage range from 2.0 V to 6.0 V
- Input levels:
  - For 74HC1G00: CMOS level
  - For 74HCT1G00: TTL level
- Symmetrical output impedance
- High noise immunity
- Low power dissipation
- Balanced propagation delays
- ESD protection:
  - HBM JESD22-A114E exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

#### **Ordering information** 3.

#### Table 1. **Ordering information**

Type number	Package							
	Temperature range	Name	Description	Version				
74HC1G00GW	–40 °C to +125 °C	TSSOP5	plastic thin shrink small outline package; 5 leads;	SOT353-1				
74HCT1G00GW			body width 1.25 mm					
74HC1G00GV	–40 °C to +125 °C	SC-74A	plastic surface-mounted package; 5 leads	SOT753				
74HCT1G00GV	_							

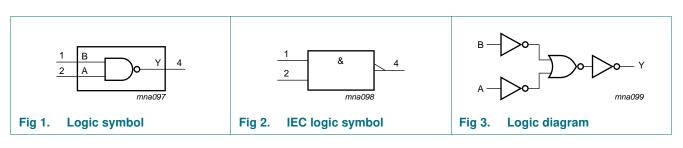


# 4. Marking

Table 2.   Marking codes	
Type number	Marking <sup>[1]</sup>
74HC1G00GW	НА
74HCT1G00GW	ТА
74HC1G00GV	H00
74HCT1G00GV	Т00

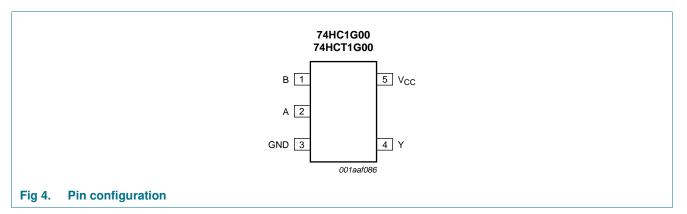
[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

# 5. Functional diagram



# 6. Pinning information

# 6.1 Pinning



## 6.2 Pin description

Table 3.	Pin description	
Symbol	Pin	Description
В	1	data input
Α	2	data input
GND	3	ground (0 V)
Y	4	data output
V <sub>CC</sub>	5	supply voltage

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# 7. Functional description

### Table 4. Function table

H = HIGH voltage level; L = LOW voltage level

Input		Output
Α	В	Y
L	L	Н
L	Н	Н
Н	L	Н
Н	Н	L

# 8. Limiting values

### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	$V_{\rm I} < -0.5$ V or $V_{\rm I} > V_{\rm CC}$ + 0.5 V	-	±20	mA
Ι <sub>ΟΚ</sub>	output clamping current	$V_O < -0.5$ V or $V_O > V_{CC}$ + 0.5 V	-	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±12.5	mA
I <sub>CC</sub>	supply current		-	25	mA
I <sub>GND</sub>	ground current		-25	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to \ +125 \ ^{\circ}C$	[2] _	200	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] Above 55 °C, the value of  $P_{tot}$  derates linearly with 2.5 mW/K.

# 9. Recommended operating conditions

### Table 6. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	74HC <sup>-</sup>	74HC1G00		74HCT1G00			Unit
			Min	Тур	Max	Min	Тур	Max	
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	$V_{CC}$	0	-	$V_{CC}$	V
Vo	output voltage		0	-	V <sub>CC</sub>	0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		-40	+25	+125	-40	+25	+125	°C
$\Delta t / \Delta V$	input transition rise and fall rate	$V_{CC} = 2.0 V$	-	-	625	-	-	-	ns/V
		$V_{CC} = 4.5 V$	-	-	139	-	-	139	ns/V
		$V_{CC} = 6.0 V$	-	-	83	-	-	-	ns/V

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Product data sheet

# **10. Static characteristics**

### Table 7. Static characteristics

Voltages are referenced to GND (ground = 0 V). All typical values are measured at  $T_{amb}$  = 25 °C.

Symbol	Parameter	Conditions	-40	–40 °C to +85 °C			–40 °C to +125 °C		
			Min	Тур	Max	Min	Max		
For type	74HC1G00								
VIH	HIGH-level input	$V_{CC} = 2.0 V$	1.5	1.2	-	1.5	-	V	
	voltage	V <sub>CC</sub> = 4.5 V	3.15	2.4	-	3.15	-	V	
		$V_{\rm CC} = 6.0 \ V$	4.2	3.2	-	4.2	-	V	
V <sub>IL</sub>	LOW-level input	$V_{CC} = 2.0 V$	-	0.8	0.5	-	0.5	V	
	voltage	V <sub>CC</sub> = 4.5 V	-	2.1	1.35	-	1.35	V	
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	-	1.8	V	
V <sub>OH</sub>	HIGH-level output	$V_{I} = V_{IH} \text{ or } V_{IL}$							
	voltage	$I_{O} = -20 \ \mu A; V_{CC} = 2.0 \ V$	1.9	2.0	-	1.9	-	V	
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 4.5 \ \text{V}$	4.4	4.5	-	4.4	-	V	
		$I_{O} = -20 \ \mu A; V_{CC} = 6.0 \ V$	5.9	6.0	-	5.9	-	V	
		$I_{O}$ = -2.0 mA; $V_{CC}$ = 4.5 V	4.13	4.32	-	3.7	-	V	
		$I_{O} = -2.6 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.63	5.81	-	5.2	-	۷	
V <sub>OL</sub>	LOW-level output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}$							
		$I_{O} = 20 \ \mu A; V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	۷	
		$I_{O} = 20 \ \mu A; V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	۷	
		$I_{O} = 20 \ \mu A; V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	۷	
		$I_{O}$ = 2.0 mA; $V_{CC}$ = 4.5 V	-	0.15	0.33	-	0.4	۷	
		$I_{O}$ = 2.6 mA; $V_{CC}$ = 6.0 V	-	0.16	0.33	-	0.4	V	
lı	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0$ V	-	-	1.0	-	1.0	μA	
I <sub>CC</sub>	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or } GND; \ I_{O} = 0 \ A; \\ V_{CC} = 6.0 \ V \end{array}$	-	-	10	-	20	μA	
Cı	input capacitance		-	- 1.5	-	-	-	pF	
For type	74HCT1G00								
V <sub>IH</sub>	HIGH-level input voltage	$V_{CC} = 4.5 V$ to 5.5 V	2.0	1.6	-	2.0	-	V	
V <sub>IL</sub>	LOW-level input voltage	$V_{CC}$ = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	V	
V <sub>ОН</sub>	HIGH-level output	$V_{I} = V_{IH} \text{ or } V_{IL}$							
	voltage	$I_O$ = –20 $\mu A;V_{CC}$ = 4.5 V	4.4	4.5	-	4.4	-	V	
		$I_{O}$ = -2.0 mA; $V_{CC}$ = 4.5 V	4.13	4.32	-	3.7	-	V	
V <sub>OL</sub>	LOW-level output	$V_{I} = V_{IH} \text{ or } V_{IL}$							
	voltage	$I_{O} = 20 \ \mu A; V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	V	
		$I_{O}$ = 2.0 mA; $V_{CC}$ = 4.5 V	-	0.15	0.33	-	0.4	V	
I	input leakage current	$V_{I} = V_{CC}$ or GND; $V_{CC} = 5.5 V$	-	-	1.0	-	1.0	μA	

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Voltages a	re referenced to GND (g	round = 0 V). All typical values are	measu	red at T	amb = 25	°C.		
Symbol	Parameter	Conditions	–40 °C to +85 °C			–40 °C	Unit	
			Min	Тур	Max	Min	Max	
I <sub>CC</sub>	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or } GND; \ I_{O} = 0 \ A; \\ V_{CC} = 5.5 \ V \end{array}$	-	-	10	-	20	μA
$\Delta I_{CC}$	additional supply current	per input; V <sub>CC</sub> = 4.5 V to 5.5 V; V <sub>I</sub> = V <sub>CC</sub> - 2.1 V; I <sub>O</sub> = 0 A	-	-	500	-	850	μA
CI	input capacitance		-	1.5	-	-	-	pF

### Table 7. Static characteristics ...continued

# **11. Dynamic characteristics**

### Table 8. Dynamic characteristics

GND = 0 V;  $t_r = t_f \le 6.0 \text{ ns}$ ; All typical values are measured at  $T_{amb} = 25 \text{ °C}$ . For test circuit, see Figure 6

Symbol	Parameter	Conditions		-40	) °C to +8	35 °C	–40 °C	Unit	
			-	Min	Тур	Max	Min	Max	
For type	74HC1G00		I			I	1	1	
t <sub>pd</sub>	propagation delay	A and B to Y; see Figure 5	[1]						
		$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$		-	25	115	-	135	ns
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		-	9	23	-	27	ns
		$V_{CC} = 5.0 \text{ V}; C_{L} = 15 \text{ pF}$		-	7	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$		-	8	20	-	23	ns
C <sub>PD</sub>	power dissipation capacitance	$V_I = GND$ to $V_{CC}$	[2]	-	19	-	-	-	pF
For type	74HCT1G00								
t <sub>pd</sub>	propagation delay	A and B to Y; see Figure 5	<u>[1]</u>						
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		-	12	24	-	27	ns
		$V_{CC} = 5.0 \text{ V}; C_{L} = 15 \text{ pF}$		-	10	-	-	-	ns
C <sub>PD</sub>	power dissipation capacitance	$V_{I}$ = GND to $V_{CC}$ – 1.5 V	[2]	-	21	-	-	-	pF

[1]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

[2]  $C_{PD}$  is used to determine the dynamic power dissipation  $P_D$  ( $\mu W$ ).

$$\begin{split} P_{D} &= C_{PD} \times V_{CC}{}^{2} \times f_{i} + \sum \left(C_{L} \times V_{CC}{}^{2} \times f_{o}\right) \text{ where:} \\ f_{i} &= \text{input frequency in MHz; } f_{o} &= \text{output frequency in MHz} \end{split}$$

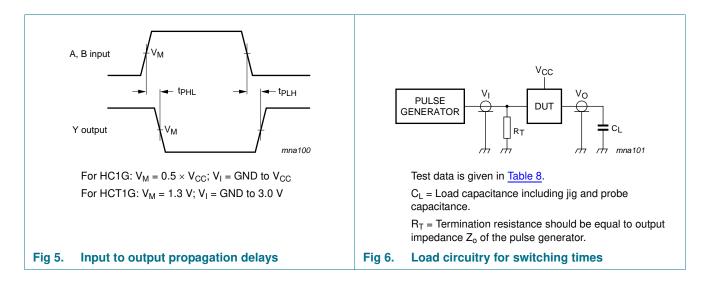
 $C_L$  = output load capacitance in pF

 $V_{CC}$  = supply voltage in Volts

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs}$ 

2-input NAND gate

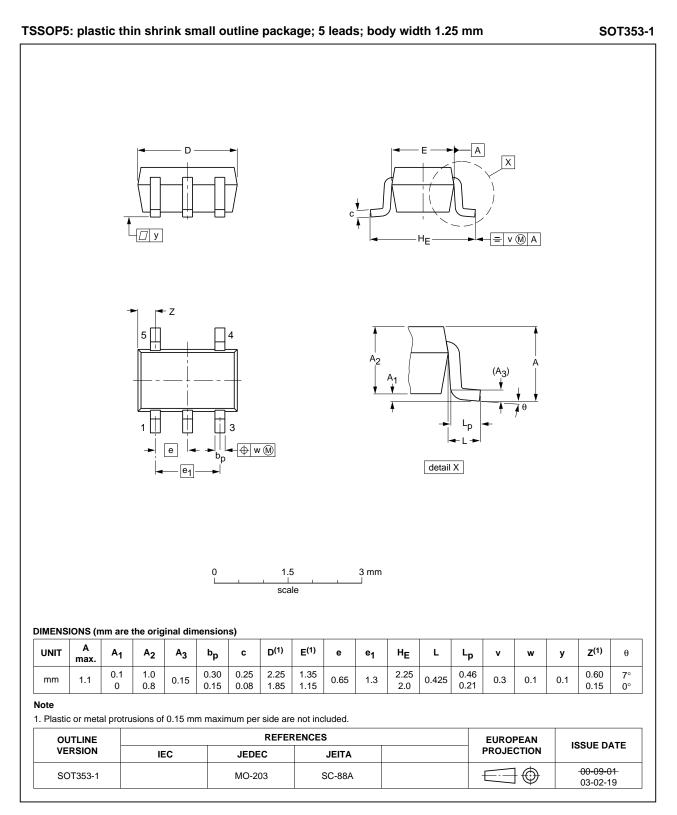
# 12. Waveforms



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2-input NAND gate

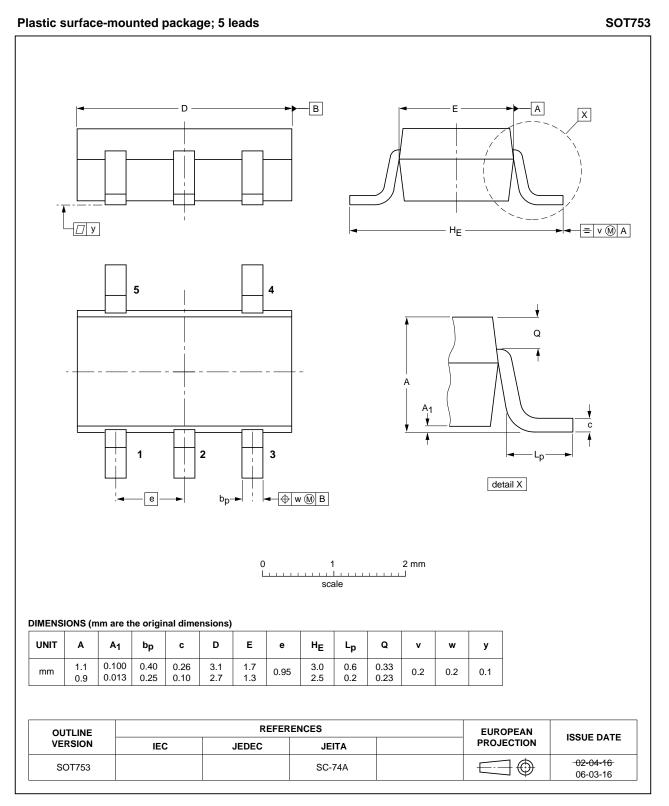
# 13. Package outline



### Fig 7. Package outline SOT353-1 (TSSOP5)

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74HC\_HCT1G00



### Fig 8. Package outline SOT753 (SC-74A)

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74HC\_HCT1G00

# 14. Abbreviations

Table 9.	Abbreviations
Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

# 15. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT1G00 v.5	20130925	Product data sheet	-	74HC_HCT1G00 v.4
Modifications:	<ul> <li>Section 1 "G</li> </ul>	eneral description" updated.		
74HC_HCT1G00 v.4	20070711	Product data sheet	-	74HC_HCT1G00 v.3
Modifications:		of this data sheet has been rea f NXP Semiconductors.	designed to comply w	vith the new identity
	<ul> <li>Legal texts h</li> </ul>	have been adapted to the new	company name whe	ere appropriate.
	<ul> <li>Package SO</li> </ul>	T353 changed to SOT353-1 i	in <u>Section 3</u> and <u>Sec</u> t	<u>ion 13</u> .
	<ul> <li>Quick refere</li> </ul>	nce data and Soldering section	ons removed.	
	Section 2 "Fe	eatures and benefits" updated	d.	
74HC_HCT1G00 v.3	20020515	Product specification	-	74HC_HCT1G00 v.2
74HC_HCT1G00 v.2	20010302	Product specification	-	74HC_HCT1G00 v.1
74HC_HCT1G00 v.1	19980730	Preliminary specification	-	-

# 16. Legal information

### 16.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product data sheet

### 2-input NAND gate

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Date of release: 25 September 2013 Document identifier: 74HC\_HCT1G00